

Notice of References Cited

Application/Control No.

10/553,284

Applicant(s)/Patent Under
Reexamination
SCHULZ ET AL.

Examiner

WILLIAM P. BELL

Art Unit

1791

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,649,622 A	08-1953	AUGUSTUS PICCARD JOHN	264/126
*	B	US-5,071,597 A	12-1991	D'Amato et al.	264/1.34
*	C	US-5,541,762 A	07-1996	Levy, George S.	359/240
*	D	US-5,849,414 A	12-1998	Bier et al.	428/412
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05045503 A	02-1993	Japan	NAKANO et al.	G02B 01/12
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Veeco Ion Beam Equipment Inc., "Mark II+ High Output Ion Source" Data Sheet, http://www.veeco.com/pdfs/datasheets/062794%20b_vc%20mark%20ii%20hces%20ds.pdf
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.